DATA SHEET

74LVCU04A
Hex inverter

Product specification

1998 Jul 29







Hex inverter 74LVCU04A

FEATURES

- Wide supply voltage range of 1.2 V to 3.6 V
- In accordance with JEDEC standard no. 8-1A.
- Inputs accept voltages up to 5.5 V
- CMOS low power consumption
- Direct interface with TTL levels

DESCRIPTION

The 74LVCU04A is a high-performance, low-power, low-voltage, Si-gate CMOS device and superior to most advanced CMOS compatible TTL families.

The 74LVCU04A is a general purpose hex inverter. Each of the six inverters is a single stage with unbuffered outputs.

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25^{\circ}C$; $t_{r} = t_{f} \le 2.5 \text{ ns}$

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t _{PHL} /t _{PLH}	Propagation delay nA to nY	$C_L = 50 \text{ pF};$ $V_{CC} = 3.3 \text{ V}$	4.3	ns
C _I	Input capacitance		7.8	pF
C _{PD}	Power dissipation capacitance per gate	Notes 1 and 2	16.8	pF

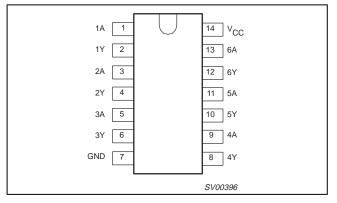
NOTES:

- 1. C_{PD} is used to determine the dynamic power dissipation(P_D in μW) V_{PD} is used to determine the dynamic power dissipation(P_D in $P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o)$ where: f_i = input frequency in MHz; C_L = output load capacity in pF; f_0 = output frequency in MHz; V_{CC} = supply voltage in V; $\sum (C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.
- 2. The condition is $V_I = GND$ to V_{CC} .

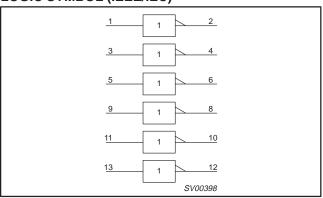
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
14-Pin Plastic SO	-40°C to +85°C	74LVCU04A D	74LVCU04A D	SOT108-1
14-Pin Plastic SSOP Type II	-40°C to +85°C	74LVCU04A DB	74LVCU04A DB	SOT337-1
14-Pin Plastic TSSOP Type I	-40°C to +85°C	74LVCU04A PW	74LVCU04APW DH	SOT402-1

PIN CONFIGURATION



LOGIC SYMBOL (IEEE/IEC)

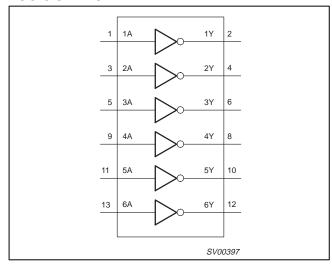


PIN DESCRIPTION

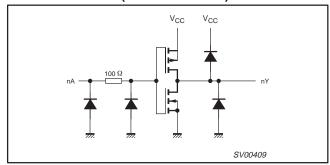
PIN NUMBER	SYMBOL	NAME AND FUNCTION				
1, 3, 5, 9, 11, 13	1A – 6A	Data inputs				
2, 4, 6, 8, 10, 12	1Y – 6Y	Data outputs				
7	GND	Ground (0 V)				
14	V _{CC}	Positive supply voltage				

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LOGIC SYMBOL



LOGIC DIAGRAM (ONE INVERTER)



FUNCTION TABLE

INPUTS	OUTPUTS
nA	nY
L	Н
Н	L

NOTES:

H = HIGH voltage level L = LOW voltage level

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	LIM	ITS	UNIT	
STINIBUL	PARAMETER	CONDITIONS	MIN	MAX	ONIT	
V _{CC}	DC supply voltage (for max. speed performance)		2.7	3.6	V	
V _{CC}	DC supply voltage (for low-voltage applications)		1.2	3.6	V	
VI	DC input voltage range		0	5.5	V	
V _{I/O}	DC output voltage range; output HIGH or LOW state		0	V _{CC}	V	
V 1/O	DC input voltage range; output 3-State		0	5.5	V	
T _{amb}	Operating free-air temperature range		-40	+85	°C	
t _r , t _f	Input rise and fall times	$V_{CC} = 1.2 \text{ to } 2.7 \text{V}$ $V_{CC} = 2.7 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V	

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ABSOLUTE MAXIMUM RATINGS¹

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to GND (ground = 0V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +6.5	V
I _{IK}	DC input diode current	$V_I < 0$	-50	mA
VI	DC input voltage	Note 2	-0.5 to +6.5	V
I _{OK}	DC output diode current	$V_{O} > V_{CC}$ or $V_{O} < 0$	±50	mA
\/	DC output voltage; output HIGH or LOW	Note 2	-0.5 to V _{CC} +0.5	V
V _{I/O}	DC input voltage; output 3-State	Note 2	-0.5 to 6.5	V
Io	DC output source or sink current	$V_O = 0$ to V_{CC}	±50	mA
I _{GND} , I _{CC}	DC V _{CC} or GND current		±100	mA
T _{stg}	Storage temperature range		–65 to +150	°C
P _{TOT}	Power dissipation per package – plastic mini-pack (SO) – plastic shrink mini-pack (SSOP and TSSOP)	above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	500 500	mW

NOTES:

DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0V).

			ı	IMITS		
SYMBOL	PARAMETER	TEST CONDITIONS	Temp = -	40°C to ⋅	+85°C	UNIT
			MIN	TYP ¹	MAX	1
		$V_{CC} = 1.2 \text{ V;} V_{OL}(\text{max}) = 0.5 \text{ V;} I_{O} = -100 \mu\text{A}$	V _{CC}			
		$V_{CC} = 2.0 \text{ V}; V_{OL}(\text{max}) = 0.5 \text{ V}; I_{O} = -100 \mu\text{A}$	1.2			1
V_{IH}	HIGH level Input voltage	$V_{CC} = 2.7 \text{ V}; V_{OL}(\text{max}) = 0.5 \text{ V}; I_{O} = -100 \mu\text{A}$	1.8			V
		$V_{CC} = 3.0 \text{ V}; V_{OL}(\text{max}) = 0.5 \text{ V}; I_{O} = -100 \mu\text{A}$	2.0			1
		$V_{CC} = 3.6 \text{ V}; V_{OL}(\text{max}) = 0.5 \text{ V}; I_{O} = -100 \mu\text{A}$	2.4			1
		$V_{CC} = 1.2 \text{ V}; V_{OH}(\text{min}) = V_{CC} - 0.5 \text{ V}; I_{O} = 100 \mu\text{A}$			GND	
		$V_{CC} = 2.0 \text{ V}; V_{OH}(\text{min}) = V_{CC} - 0.5 \text{ V}; I_{O} = 100 \mu\text{A}$			0.6	1
V_{IL}	LOW level Input voltage	$V_{CC} = 2.7 \text{ V; } V_{OH}(\text{min}) = V_{CC} - 0.5 \text{ V; } I_{O} = 100 \mu\text{A}$			0.6	V
		$V_{CC} = 3.0 \text{ V}; V_{OH}(\text{min}) = V_{CC} - 0.5 \text{ V}; I_{O} = 100 \mu\text{A}$			1.0]
		$V_{CC} = 3.6 \text{ V; } V_{OH}(\text{min}) = V_{CC} - 0.5 \text{ V; } I_{O} = 100 \mu\text{A}$			1.2	
		$V_{CC} = 2.7 \text{ V}$; V_{CC} or GND; $I_{O} = -12 \text{ mA}$	V _{CC} - 0.5			
V	HICH level output voltage	$V_{CC} = 3.0 \text{ V; } V_{CC} \text{ or GND; } I_{O} = -100 \mu\text{A}$	V _{CC} -0.2	V _{CC}		
V _{OH}	HIGH level output voltage	$V_{CC} = 3.0 \text{ V}$; V_{CC} or GND; $I_{O} = -12 \text{ mA}$	V _{CC} -0.6			1 °
		$V_{CC} = 3.0 \text{ V}$; V_{CC} or GND; $I_{O} = -24 \text{ mA}$	V _{CC} -1.0			
		$V_{CC} = 2.7 \text{ V}$; V_{CC} or GND; $I_{O} = 12 \text{ mA}$			0.40	
V _{OL}	LOW level output voltage	$V_{CC} = 3.0 \text{ V}; V_{CC} \text{ or GND}; 12\text{mA}; I_{O} = 100\mu\text{A}$			0.20	V
		$V_{CC} = 3.0 \text{ V}; V_{CC} \text{ or GND}; I_{O} = 24\text{mA}$			0.55	<u> </u>
l ₁	Input leakage current	V _{CC} = 3.6 V; 5.5 V or GND; Not for I/O pins		±0.1	±5	μΑ
I _{CC}	Quiescent supply current	$V_{CC} = 3.6 \text{ V}; V_{CC} \text{ or GND}; I_{O} = 0$		0.1	10	μΑ

NOTE

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

^{1.} Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

^{2.} The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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AC CHARACTERISTICS

GND = 0 V; t_r = $t_f \leq$ 2.5 ns; C_L = 50 pF; R_L = 500 Ω ; T_{amb} = -40°C to +85°C

			LIMITS						
SYMBOL PARAMETER		WAVEFORM	V _{CC}	= 3.3V ±0).3V	V _{CC} =	2.7V	V _{CC} = 1.2V	UNIT
			MIN	TYP ¹	MAX	MIN	MAX	TYP]
t _{PHL} /	Propagation delay nA to nY	Figure 1	-	2.7	4.3	_	5.3	-	ns

NOTE:

1. These typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

AC WAVEFORM

 $V_M = 1.5 \text{ V at } V_{CC} \ge 2.7 \text{ V}$

 $V_M = 0.5 \cdot V_{CC}$ at $V_{CC} < 2.7 \text{ V}$

 V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

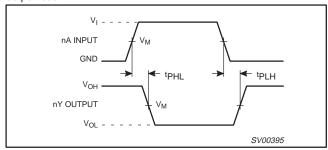


Figure 1. Input (nA) to output (nY) propagation delays.

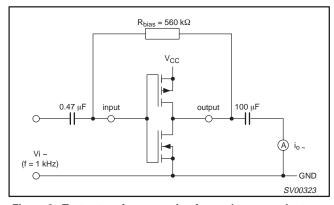


Figure 2. Test set-up for measuring forward transconductance $g_{fs} = di_o/dv_i$ at v_o is constant (see also graph Figure 3).

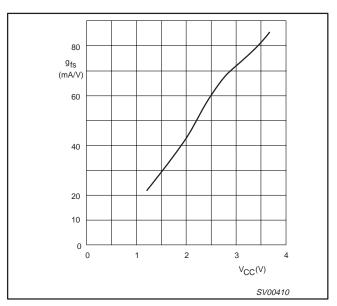


Figure 3. Typical forward transconductance g_{fs} as a function of the supply voltage V_{CC} at $T_{amb} = 25\,^{\circ}C$.

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APPLICATION INFORMATION

Some applications for the 74LVU04 are:

- Linear amplifier (see Figure 4)
- In crystal oscillator designs (see Figure 5)
- Astable multivibrator (see Figure 6)

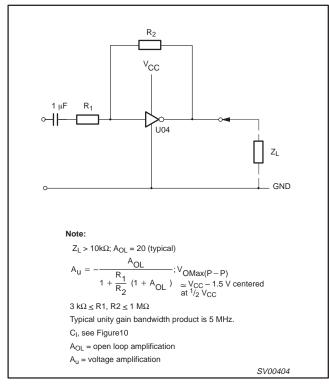


Figure 4. LVU04 used as a linear amplifier.

Note to Figure 4

$$\begin{split} Z_L > &10 \text{ k}\Omega; \text{ A}_{OL} = 20 \text{ (typical)} \\ A_u = &-\frac{A_{OL}}{1 + \frac{R_1}{R_2} \left(1 + A_{OL}\right)} \; ; \begin{array}{l} V_{O \text{ Max } (P-P)} \\ \approx V_{CC} - 1.5 \text{ V centered} \\ \text{at } \frac{1}{2} V_{CC} \end{array} \end{split}$$

 $3 \text{ k}\Omega \leq \text{R1}, \text{R2} \leq 1 \text{ M}\Omega$

Typical unity gain bandwidth product is 50 MHz.

A_{OL} = open loop amplification

 A_u = voltage amplification

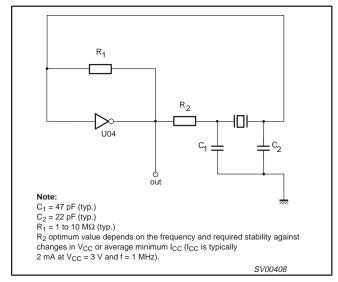


Figure 5. Crystal oscillator configuration.

Note to Figure 5

 $C_1 = 47 \text{ pF (typ.)}$ $C_2 = 22 \text{ pF (typ.)}$ $R_1 = 1 \text{ to } 10 \text{ M}\Omega \text{ (typ.)}$

 R_2 optimum value depends on the frequency and required stability against changes in V_{CC} or average minimum $I_{CC}.$

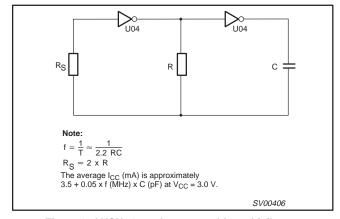


Figure 6. LVCU04 used as an astable multivibrator.

Note to Figure 6

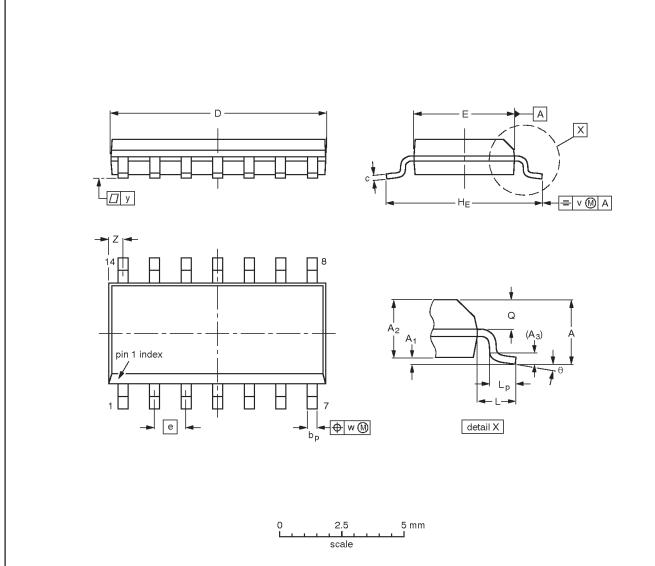
$$f = \frac{1}{T} \approx \frac{1}{2.2 \text{ RC}}$$

$$R_S\approx 2\;x\;R$$

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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽¹⁾	e	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075		0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Note

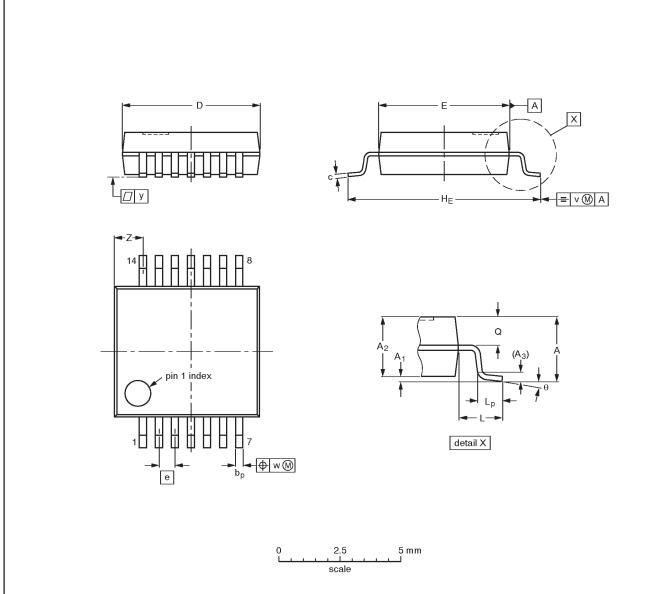
1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT108-1	076E06S	MS-012AB				-95-01-23 97-05-22

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SSOP14: plastic shrink small outline package; 14 leads; body width 5.3 mm

SOT337-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	рb	O	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	ø	٧	w	у	Z ⁽¹⁾	θ
mm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.4 0.9	8° 0°

Note

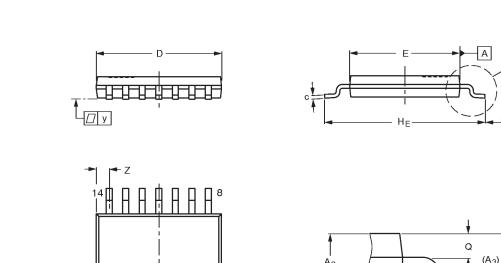
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

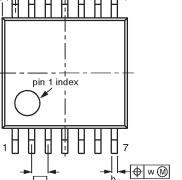
OUTLINE		EUROPEAN	ISSUE DATE			
VERSION	VERSION IEC		EIAJ		PROJECTION	ISSUE DATE
SOT337-1		MO-150AB				-95-02-04 96-01-18

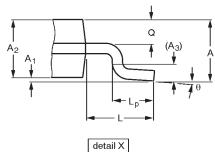
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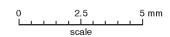
TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1









DIMENSIONS (mm are the original dimensions)

UNIT	A max.	Α1	A ₂	A ₃	bр	O	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Ø	v	w	у	Z ⁽¹⁾	θ
mm	1.10	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT402-1		MO-153			94-07-12 95-04-04	

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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